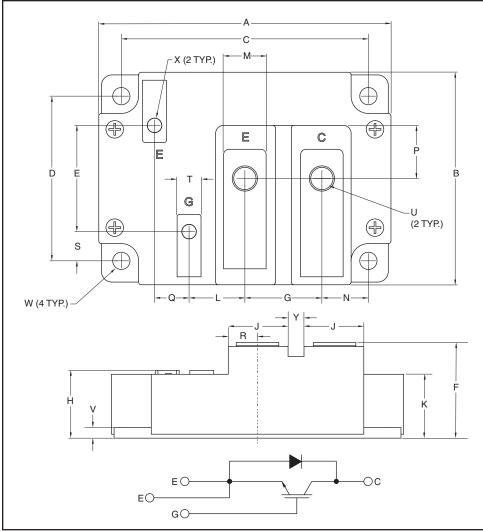
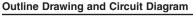


Single IGBT Module 900 Amperes/1700 Volts

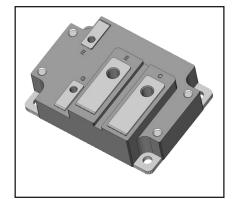


Note: All electrical characteristics scaled from 300A module CM300DX-34SA.



Dimensions	Inches	Millimeters
А	4.33	110.0
В	3.15	80.0
С	3.66±0.008	93.0±0.25
D	2.44±0.008	62.0±0.25
E	1.57	40.0
F	1.42 Max.	36.0 Max.
G	1.14	29.0
Н	1.00 Max.	25.5 Max.
J	0.89	22.5
К	0.93	23.5
L	0.83	21.0
М	0.63	16.0

Dimensions	Inches	Millimeters
N	0.69	17.5
Р	0.79	20.0
Q	0.51	13.0
R	0.43	11.0
S	0.43	11.0
Т	0.35	9.0
U	M8 Metric	M8
V	0.16	4.0
W	0.256 Dia.	6.5 Dia.
Х	M4 Metric	M4
Y	0.24	6.0



Description:

Powerex IGBT Modules are designed for use in switching applications. Each module consists of one IGBT Transistor in a single configuration with a reverse-connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

Features:

- □ Low Drive Power
- □ Low V_{CE(sat)}
- Discrete Super-Fast Recovery Free-Wheel Diode
- Isolated Baseplate for Easy Heat Sinking

Applications:

- □ AC Motor Control
- □ Motion/Servo Control
- □ Welding Power Supplies
- □ Laser Power Supplies



QIS1790001

Single IGBT Module 900 Amperes/1700 Volts

Absolute Maximum Ratings, T_j = 25°C unless otherwise specified

Characteristics	Symbol	Rating	Units
Collector-Emitter Voltage (V _{GE} = 0V)	V _{CES}	1700	Volts
Gate-Emitter Voltage (V _{CE} = 0V)	V _{GES}	±20	Volts
Collector Current (DC, T _C = TBD°C) ^{*2,*4}	Ι _C	900	Amperes
Collector Current (Pulse, Repetitive)*3	ICRM	1800	Amperes
Total Power Dissipation $(T_C = 25^{\circ}C)^{*2,*4}$	P _{tot}	TBD	Watts
Emitter Current (T _C = TBD°C)*2,*4	IE ^{*1}	900	Amperes
Emitter Current (Pulse, Repetitive)*3	I _{ERM} ^{*1}	1800	Amperes
Maximum Junction Temperature	T _{j(max)}	175	°C
Maximum Case Temperature*2	T _{C(max)}	125	°C
Operating Junction Temperature	T _{j(op)}	-40 to +150	°C
Storage Temperature	T _{stg}	-40 to +125	°C
Isolation Voltage (Terminals to Baseplate, RMS, f = 60Hz, AC 1 minute)	V _{ISO}	3500	Volts

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDi).

*2 Case temperature (T_C) and heatsink temperature (T_s) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips.

The heatsink thermal resistance should be measured just under the chips.

*3 Pulse width and repetition rate should be such that device junction temperature (T_j) does not exceed T_{j(max}) rating.
*4 Junction temperature (T_j) should not increase beyond maximum junction



QIS1790001

Single IGBT Module 900 Amperes/1700 Volts

Electrical Characteristics, $T_i = 25^{\circ}C$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Emitter Cutoff Current	ICES	$V_{CE} = V_{CES}, V_{GE} = 0V$	_	_	3	mA
Gate-Emitter Leakage Current	IGES	$V_{GE} = V_{GES}, V_{CE} = 0V$	_	_	15	μA
Gate-Emitter Threshold Voltage	V _{GE(th)}	$I_{C} = 90 \text{mA}, V_{CE} = 10 \text{V}$	5.4	6.0	6.6	Volts
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_{C} = 900A, V_{GE} = 15V, T_{j} = 25^{\circ}C^{*6}$	_	2.0	2.5	Volts
		$I_{C} = 900A, V_{GE} = 15V, T_{j} = 125^{\circ}C^{*6}$	_	2.2	_	Volts
		$I_{C} = 900A, V_{GE} = 15V, T_{j} = 150^{\circ}C^{*6}$	_	2.25	_	Volts
Input Capacitance	C _{ies}		_	_	156	nF
Output Capacitance	C _{oes}	V _{CE} = 10V, V _{GE} = 0V	_		6.6	nF
Reverse Transfer Capacitance	C _{res}		_	_	1.56	nF
Gate Charge	Q _G	V_{CC} = 1000V, I_{C} = 900A, V_{GE} = 15V	_	4968	_	nC
Turn-on Delay Time	t _{d(on)}		_	400		ns
Rise Time	t _r	$V_{CC} = 1000V, I_C = 900A, V_{GE} = \pm 15V,$	_	100	_	ns
Turn-off Delay Time	^t d(off)	$R_{G} = 0\Omega$, Inductive Load	_	700	_	ns
Fall Time	t _f		_	600		ns
Emitter-Collector Voltage	V _{EC} ^{*1}	$I_E = 900A, V_{GE} = 0V, T_j = 25^{\circ}C^{*6}$	_	4.1	5.3	Volts
		$I_E = 900A, V_{GE} = 0V, T_j = 125^{\circ}C^{*6}$	_	2.9	_	Volts
		$I_E = 900A, V_{GE} = 0V, T_j = 150^{\circ}C^{*6}$	_	2.7	_	Volts
Reverse Recovery Time	t _{rr} *1	V_{CC} = 1000V, I _E = 900A, V _{GE} = ±15V	_	_	300	ns
Reverse Recovery Charge	Q _{rr} *1	$R_{G} = 0\Omega$, Inductive Load	_	42	_	μC
Turn-on Switching Energy per Pulse	E _{on}	$V_{CC} = 1000V, I_C = I_E = 900A,$	_	114	_	mJ
Turn-off Switching Energy per Pulse	E _{off}	$V_{GE} = \pm 15V, R_G = 0\Omega,$	_	240	_	mJ
Reverse Recovery Energy per Pulse	E _{rr} *1	T _j = 150°C, Inductive Load	_	207	_	mJ
Internal Lead Resistance	R _{CC' + EE'}	Main Terminals-Chip,	_	_	TBD	mΩ
		$T_{C} = 25^{\circ}C^{*2}$				
Internal Gate Resistance	rg		_	0.56	_	Ω

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDi).

*2 Case temperature (T_C) and heatsink temperature (T_s) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. The heatsink thermal resistance should be measured just under the chips.

*6 Pulse width and repetition rate should be such as to cause negligible temperature rise.



QIS1790001 Single IGBT Module 900 Amperes/1700 Volts

Electrical Characteristics, T_j = 25°C unless otherwise specified (continued)

Thermal Resistance Characteristics

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Thermal Resistance, Junction to Case*2	R _{th(j-c)} Q	Per Inverter IGBT	_	18	_	K/kW
Thermal Resistance, Junction to Case*2	R _{th(j-c)} D	Per Inverter FWDi	_	28	_	K/kW
Contact Thermal Resistance,	R _{th(c-f)}	Thermal Grease Applied	_	15	_	K/kW
Case to Heatsink ^{*2}						

Mechanical Characteristics

Mounting Torque		Mounting to Terminal, M8 Screw	_	_	95	in-lb
	_	Mounting to Terminal, M4 Screw	_	_	15	in-lb
	_	Mounting to Heatsink, M6 Screw	_	_	40	in-lb
Creepage Distance	d _s	Terminal to Terminal	TBD	_		mm
	_	Terminal to Baseplate	TBD	_	_	mm
Clearance	d _a	Terminal to Terminal	TBD	_	_	mm
	_	Terminal to Baseplate	TBD	_	_	mm
Weight	m		_	600		Grams
Flatness of Baseplate	e _c	On Centerline X, Y	-100	_	+100	μm

Recommended Operating Conditons, Ta = 25°C

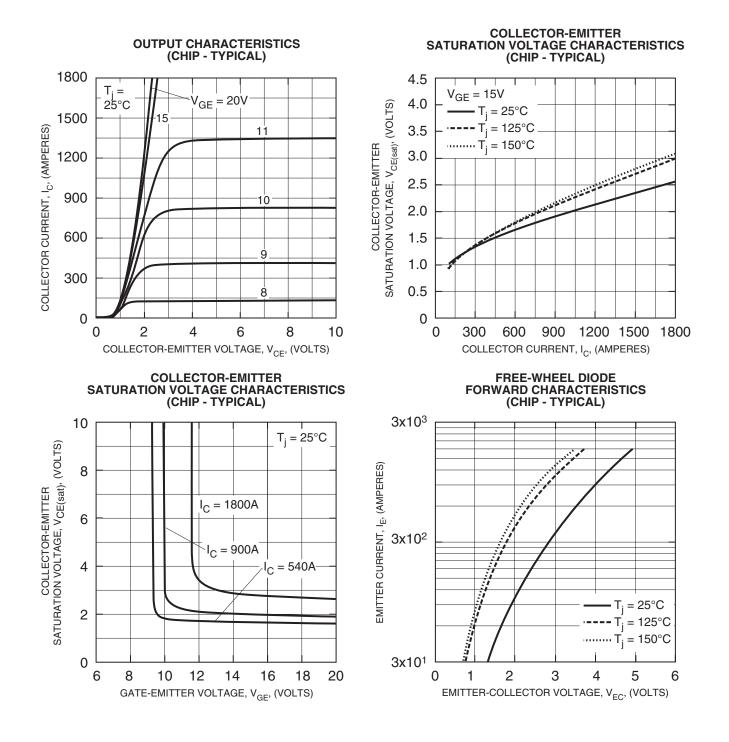
(DC) Supply Voltage	V _{CC}	Applied Across C-E	_	1000	1200	Volts
Gate (-Emitter Drive) Voltage	V _{GE(on)}	Applied Across G-E	13.5	15.0	16.5	Volts
External Gate Resistance	R _G	Per Switch	0	—	9	Ω

*2 Case temperature (T_C) and heatsink temperature (T_S) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. The heatsink thermal resistance should be measured just under the chips.



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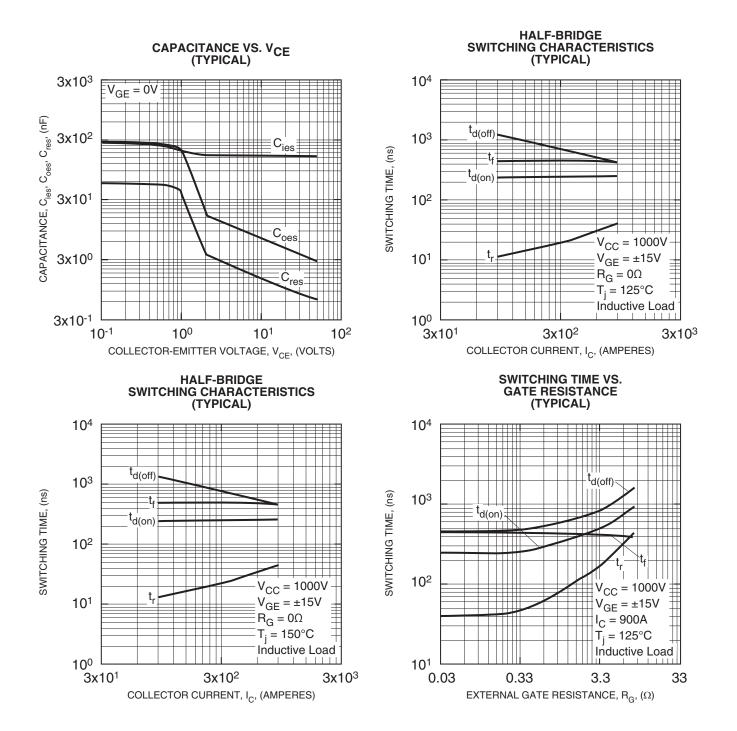
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